

10/05/931


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Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
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 image <and> encod\* <and>  
 similarity

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```
(image <near/5> encod*) <and>
similar*
```

 

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(image <near/5> encod\*) <and>  
(image <near/4> recogni\*)**Start Search** **Clear**

Note: This function returns plural and suffixed forms of the keyword(s).

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```
(correlat* <or>
crosscorrelat*) <near/8> (dct
<or> fourier <or> transform)
<and> coefficient <and> image
```

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